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Small Angle X-Ray Scattering of Neutron- and Electron-
Irradiated Pd₈₀Si₂₀ Amorphous Alloy*

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Synopsis

Small angle X-ray scattering (SAXS) was measured for neutron- and electron-irradiated Pd₈₀Si₂₀ amorphous alloy. The experimental SAXS intensity curves are well approximated by the Guinier formula below $h=0.04 \text{ \AA}^{-1}$. The radii of gyration are almost same between electron-irradiated and aged sample, while neutron-irradiated sample shows a small radius of gyration.

I. Introduction

Small angle X-ray scattering is a well suited technique for investigating the atomic density fluctuation over the region from about 10 to 1000 Å. As amorphous alloys are in the non-equilibrium state with disordered atomic arrangement, it is expected that the atomic density fluctuation in amorphous alloys produced by electron- and/or neutron-irradiation shows a characteristic behaviour different from that in crystalline alloys.

The neutron-irradiation effect for Pd₈₀Si₂₀ amorphous alloy has been so far investigated by using various kinds of experimental technique^{1),2)}. Itoh et al.¹⁾ found from positron annihilation experiment that discrete voids as observed in crystalline metals were never created in Pd₈₀Si₂₀ amorphous alloy. Concerning X-ray structure factor $S(Q)$ for Pd₈₀Si₂₀ amorphous alloy, however both the height and the width of the first peak in $S(Q)$ suffer no appreciable change due to neutron-irradiation¹⁾. In the experiments mentioned above, the temperature during irradiating Pd₈₀Si₂₀ amorphous alloy has reached about 150 °C. Therefore, it is not elucidated whether the structural change observed is caused by irradiation or due to the rise of temperature.

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Doi et al.²⁾ measured SAXS of Pd₈₀Si₂₀ amorphous alloy which was irradiated with fast neutrons to a fluence of 5×10^{20} neutrons/cm². Based on the analysis of scattering curve near $h=0.3 \text{ \AA}^{-1}$ ($h=4\pi \sin\theta/\lambda$, 2θ :scattering angle), they concluded that structural inhomogeneities with the coherent region of about 8 Å diameter separated from each other by a mean distance of about 20 Å were produced.

In this study it is aimed at measuring SAXS of Pd₈₀Si₂₀ amorphous alloys neutron-irradiated at ambient temperature and electron-irradiated under liquid nitrogen temperature. In order to characterize large scale density fluctuation, particular attention is paid to the observation of the scattering curve below $h=0.1 \text{ \AA}^{-1}$. For comparison we measure SAXS of as-prepared and thermal annealed Pd₈₀Si₂₀ amorphous alloys, too.

II. Experimental

Pd₈₀Si₂₀ amorphous alloy sample was prepared by rapid quenching from melt under Ar-gas atmosphere of 100 Torr into a thin plate form of 10 mm×10 mm×0.02mm. Several sheets of the sample were irradiated by fast neutrons up to a fluence of 9×10^{18} n/cm² (>1MeV) using Japan Material Testing Reactor, Oarai Research Establishment, Japan Atomic Energy Research Institute (JAERI). The sample temperature was kept below 150 °C during the neutron-irradiation. Another several sheets of the sample were irradiated by 2.5 MeV electron up to a fluence of 1×10^{18} e/cm² in liquid nitrogen with the electron accelerator located at Takasaki Radiation Chemistry Research Establishment, JAERI. One sheet of the sample was aged at 290 °C for 460 min in a vacuum of 10^{-6} mmHg to result in the formation of MS-I metastable phase³⁾.

SAXS intensity curve were measured using a conventional long-slit SAXS spectrometer (Rigaku, 12 KW rotor unit), where a thick Pb-metal shield was set in front of an X-ray detecting counter to prevent the induced radiation of the irradiated sample from striking the detector. The spectrometer used may be regarded as equipping a infinitely long-slit system, if no SAXS is observed above the scattering angle of $2\theta=2.13^\circ$. All the measurements were carried out with Mo-target at 50 KV and 140 mA in a room temperature.

III. Results

The experimental scattering intensity $J(h)$ was calculated using equation (1) as follows:

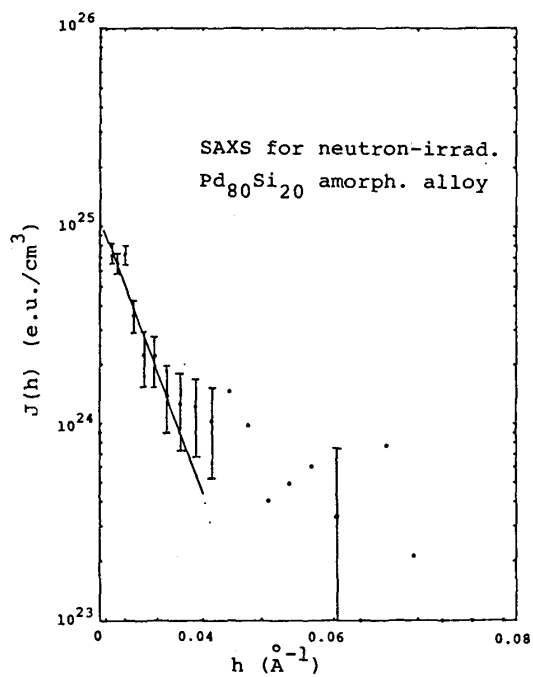


Fig.1. The Guinier plot for neutron-irradiated Pd₈₀Si₂₀ amorphous alloy

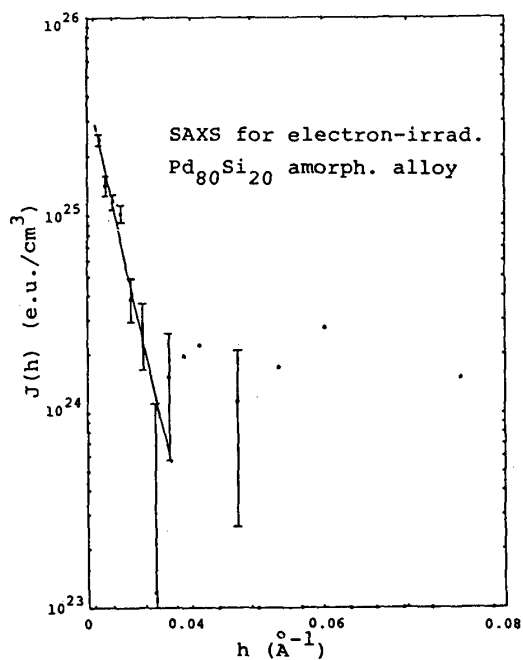


Fig.2. The Guinier plot for electron-irradiated Pd₈₀Si₂₀ amorphous alloy

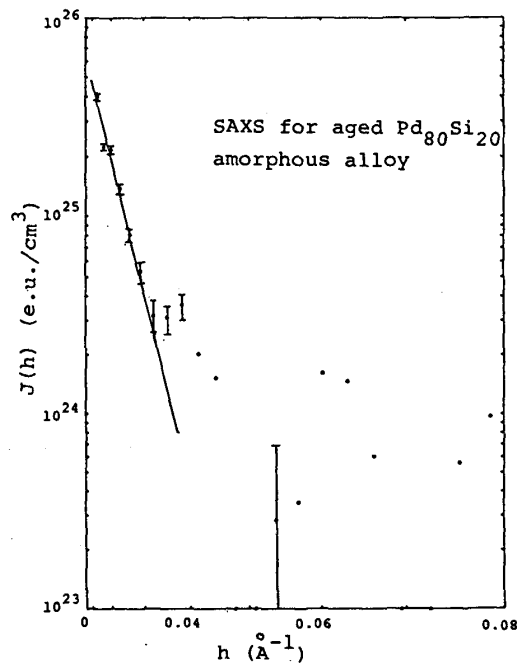


Fig.3. The Guinier plot for aged Pd₈₀Si₂₀ amorphous alloy

$$J(h) = \frac{\bar{P}_{\text{obs}}}{(\bar{P}_{\text{obs}})_{\text{Lupolen}, 150\text{\AA}}} \times \frac{1}{t \times e^{-\mu t}} \times 0.0307 \text{ (cm}^{-1}\text{)} \quad (1)$$

where $h(=4\pi\sin\theta/\lambda)$ is the scattering vector (2θ :scattering angle, λ : wave length of incident X-ray). \bar{P}_{obs} is the photon count from sample. $(\bar{P}_{\text{obs}})_{\text{Lupolen}, 150\text{\AA}}$ is the photon count from Lupolen at a Bragg angle corresponding to $d=150 \text{\AA}$, t is the sample thickness (cm) and μ is the absorption coefficient of sample.

The experimental results thus obtained for neutron-, electron-irradiated and aged sample are shown in Figs. 1 to 3 respectively. The experimental errors indicated by vertical bars in these figures mean the square-root of the sum of statistical variances of photon counts from the sample and background. The absolute values of the scattering intensity are of order of $10^{24} \text{ e.u./cm}^3$ in the irradiated and aged sample, which cannot be neglected but are relatively small. However we cannot observe the scattering intensity greater than $1 \times 10^{23} \text{ e.u./cm}^3$ for the as-prepared sample before irradiation. The observed SAXS intensity, therefore, corresponds to the effect of the irradiations and/or the thermal annealing.

Over the higher scattering vector range above $h=0.06 \text{\AA}^{-1}$, it is not possible to distinguish the photon counts scattered by the sample from that by the background. Therefore we discard Porod plot.

Below $h=0.04 \text{\AA}^{-1}$, the scattered intensities are well approximated by the Guinier formula as evidently shown in Figs 1 to 3. The values of radius of gyration R_g obtained from the Guinier plot combined with weighted least squares fitting are given as follows:

$$\begin{aligned} R_g &= 78.2 \pm 9.4 \text{\AA} && \text{for neutron-irradiated sample} \\ R_g &= 93.9 \pm 7.7 \text{\AA} && \text{for electron-irradiated sample} \\ R_g &= 94.0 \pm 4.9 \text{\AA} && \text{for annealed sample.} \end{aligned}$$

IV. Discussion

According to Masumoto et al.³⁾, the globular metastable phase so called MS-I starts to precipitate in $\text{Pd}_{80}\text{Si}_{20}$ amorphous alloy aged at $290 \text{ }^\circ\text{C}$ for 460 minutes. By measuring the diameter of the globular precipitates in the transmission electron micrograph in their work, the average diameter of the MS-I precipitates can be estimated to be about 250\AA . In the present SAXS measurements, the diameter d of the globular particle is given by $2\sqrt{5/3} R_g$ using the radius of gyration R_g . Therefore the diameter $243 \pm 13 \text{\AA}$ is obtained from the estimated value of $R_g = 94.0 \pm 4.9 \text{\AA}$. The both experiments give the nearly same values for the diameter of the annealing precipitate in $\text{Pd}_{80}\text{Si}_{20}$

amorphous alloy.

As well known, only one or two pairs of Frenkel-type defect are produced in the crystalline metal irradiated by electron beam of about 1 MeV. Therefore the value of R_g in irradiated metals must be the order of several \AA . The experimental value of R_g is quite larger than the representative value of Frenkel-type defect. Furthermore the scattering intensity of the electron-irradiated sample has a nearly same pattern as that of the aged sample. These facts suggest that some crystalline precipitates such as MS-I may be accelerated in $\text{Pd}_{80}\text{Si}_{20}$ amorphous alloy even at liquid nitrogen temperature by electron beam irradiation. The acceleration of crystallization by room temperature electron-irradiation has already been found for Ni-B-Si, Ni-P-B and Ni-P amorphous alloys⁴⁾.

As for the fast neutron-irradiated $\text{Pd}_{80}\text{Si}_{20}$ amorphous alloy, Itoh et al.¹⁾ concluded from their experiments of both positron annihilation and X-ray diffraction that the voids larger than single vacancy were not produced by neutron-irradiation without any sign of crystalline precipitation.

The average energy of neutrons used for irradiating $\text{Pd}_{80}\text{Si}_{20}$ amorphous alloy is about 2 MeV. Using the Kinchin-Pease model, the approximated number of atoms displaced by 2 MeV neutron collision is given $(1/A) \times (E_n/E_d) \sim (1/100) \times (2 \times 10^6 / 25) = 800$, where A is the atomic number, E_n is the neutron energy and E_d is the atomic displacement energy. Since the volume per $\text{Pd}_{0.8}\text{Si}_{0.2}$ molecular formula is 14.3\AA^3 in $\text{Pd}_{80}\text{Si}_{20}$ amorphous alloy, the spatial fluctuation extending over $14.3 \times 800 = 1.14 \times 10^4 \text{\AA}^3$ can be brought about by one neutron. If the shape of the fluctuation induced by neutron-irradiation is supposed to be spherical, its volume is $(4\pi/3) \times (5R_g/3)^3 = (4.3 \pm 1.7) \times 10^6 \text{\AA}^3$ using the radius of gyration $R_g = 78.2 \text{--} 9.4 \text{\AA}$ estimated in Fig.1. This value is much larger than the value estimated above. Therefore, the shape of the fluctuation brought about into $\text{Pd}_{80}\text{Si}_{20}$ amorphous alloy by neutron-irradiation can not be approximated by the sphere. When the shape is approximated by an ellipsoid of revolution (a, a, va) , of which volume is $(4\pi/3)va^3 \sim 1.14 \times 10^4 \text{\AA}^3$ and radius of gyration is $\sqrt{(2+v^2)}/5 \times a \sim 78.3 \text{\AA}$, we obtain two different types of the shape, a prolate of $v=43$, $a=4 \text{\AA}$ and an oblate of $v=1.5 \times 10^{-3}$, $a=122 \text{\AA}$. A prolate $(4 \text{\AA}, 4 \text{\AA}, 170 \text{\AA})$ may be more realistic than an oblate $(122 \text{\AA}, 122 \text{\AA}, 0.18 \text{\AA})$.

V. Conclusion

- (1) From the results of SAXS experiments, it is found that the larger region of spatial fluctuation is produced by the low temperature electron irradiation compared with the neutron irradiation in $\text{Pd}_{80}\text{Si}_{20}$ amorphous alloy.
- (2) The similarity of the SAXS results between the electron-irradiated and the aged $\text{Pd}_{80}\text{Si}_{20}$ amorphous alloy suggests that the electron irradiation may accelerate the crystallization of $\text{Pd}_{80}\text{Si}_{20}$ amorphous alloy such as metastable phases like MS-I state even at liquid nitrogen temperature.
- (3) On the contrary, the neutron irradiation gives the spatial fluctuation with the radius of gyration of $R_g=78.2\pm 9.4 \text{ \AA}$ in $\text{Pd}_{80}\text{Si}_{20}$ amorphous alloy. Consideration of the number of displaced atoms suggests that this spatial fluctuation has non-spherical shape (i.e., prolate or oblate) which still preserves the amorphous state.

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